



Product data sheet

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PRTR5V0U2X-MS

Semiconductor Compiance

Feature

350 W Peak Power per Line (tp = 8/20μs) SOT-143 package ESD Protection > 15 kV Unidirectional configurations Protects 2 I/O Ports & Power Supply Low Capacitance: 4 pF Low clamping voltage RoHS Compliant in Lead-Free Versions Transient protection for data lines to IEC 61000-4-2(ESD) ±15KV(air) ±8KV(contact); IEC 61000-4-4 (EFT) 40A (5/50ns)

Mechanical Characteristics

Lead finish:100% matte Sn(Tin) Mounting position: Any Qualified max reflow temperature:260°C Device meets MSL 1 requirements Pure tin plating: 7 ~ 17 um Pin flatness:≤3mil

Applications

Ethernet - 10/100 Base T Fire wire Wireless communications USB interface



SOT-143

Electrical characteristics per line@(unless otherwisespecified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Reverse Stand-off Voltage	V _{RWM}				5	V
Reverse Breakdown Voltage	V _{BR}	It = 1mA	6		8.5	V
Reverse Leakage Current	I _R	V _{RWM} =5.0V, T=25℃			1	μA
Clamping Voltage	Vc	I _{PP} = 1A, t _P = 8/20μs			12.5	V
Clamping Voltage	Vc	I _{PP} =5A, t _P = 8/20µs			24.0	V
Capacitance Between IO and GND	CJ	V _R =0V, f = 1MHz		3.0		pF
Capacitance Between IO and I/O	CJ	V _R =0V, f = 1MHz		1.5		pF

Absolute maximum rating@25℃

Rating	Symbol	Value	Units
Peak Pulse Power (t _p =8/20µs)	P _{pp}	350	W
Peak Pulse Power (t _p =8/20µs)	I _{pp}	9	А
Operating Temperature	TJ	-55 to +150	°C
Storage Temperature	T _{STG}	-55 to +150	°C



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Electronics Parameter

Symbol	Parameter		
V _{RWM}	Peak Reverse Working Voltage		
IR	Reverse Leakage Current @ V _{RWM}		
V _{BR}	Breakdown Voltage @ I _T		
Ι _Τ	Test Current		
I _{PP}	Maximum Reverse Peak Pulse Current		
Vc	Clamping Voltage @ IPP		
P _{PP}	Peak Pulse Power		
CJ	Junction Capacitance		
lF	Forward Current		
VF	Forward Voltage @ I _F		



FIG1: Pulse Waveform



FIG2:Power Derating







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PACKAGE MECHANICAL DATA



0	Inches			Millimeters			
Symbol	Min.	Nom.	Max.	Min.	Nom.	Max.	
Α	0.031	-	0.048	0.80	-	1.22	
A1	0.000	-	0.008	0.013	-	0.15	
A2	0.020	0.035	0.042	0.75	0.90	1.07	
b	0.011	-	0.020	0.30	-	0.51	
b1	0.029	-	0.037	0.76	-	0.94	
С	0.003	-	0.008	0.08	-	0.20	
D	0.110	0.114	0.120	2.80	2.90	3.04	
E	0.082	0.093	0.104	2.10	2.37	2.64	
E1	0.047	0.051	0.055	1.20	1.30	1.40	
е	0.075			1.92 BSC			
e1	0.008			0.20 BSC			
L	0.015	0.020	0.024	0.40	0.50	0.60	
L1	(0.021)			(0.54)			
N	4			4			
θ	0°	-	8°	0°	-	8°	
aaa	0.006			0.15			
bbb	0.008			0.20			
ссс	0.004			0.10			

Suggested Pad Layout



REEL SPECIFICATION

P/N	PKG	QTY
PRTR5V0U2X-MS	SOT-143	3000





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